

Hybrid IGZO-Si 3T0C DRAM for Energy-Efficient Near-Memory MAC and Bitwise computing

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Background and Motivation

The ever-widening “memory wall”—the disparity between processor speeds and DRAM access times (see Figure 1)—now dominates both performance and energy in data-intensive workloads. In-Memory Computing (IMC) directly embeds logic into the memory array, sidestepping costly data transfers. Traditional CMOS-based DRAM achieves high speed but suffers from substantial refresh overhead, whereas emerging oxide TFTs (e.g., IGZO) offer ultra-low leakage at the expense of mobility (see Figure 2).

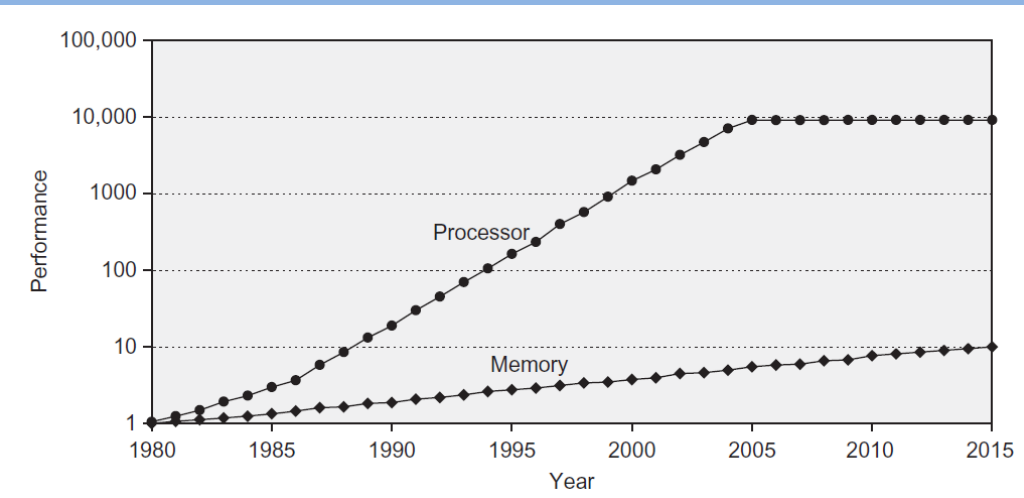


Figure 1: Processor vs. memory relative performance over the years [1, p. 80].

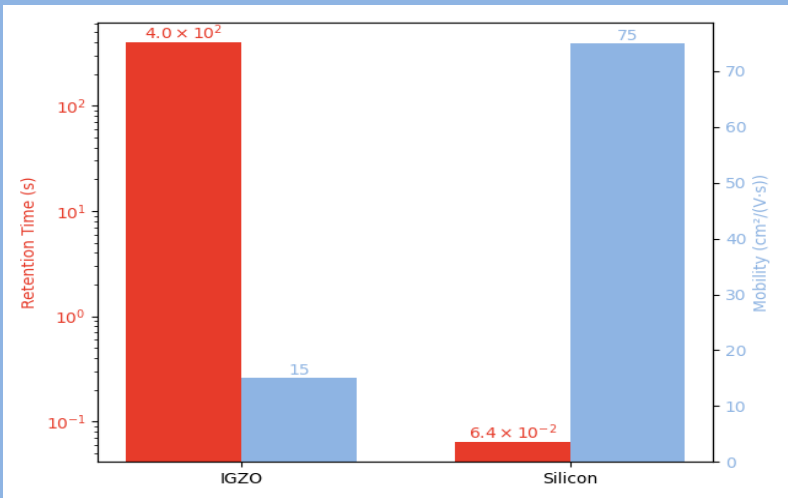


Figure 2: IGZO vs. Si: Mobility & Retention

To reconcile these trade-offs, a hybrid IGZO–Si 3-transistor/0-capacitor (3T0C) cell is proposed, marrying IGZO’s retention with silicon’s high-speed switching. This work quantifies the potential of such a hybrid cell for IMC.

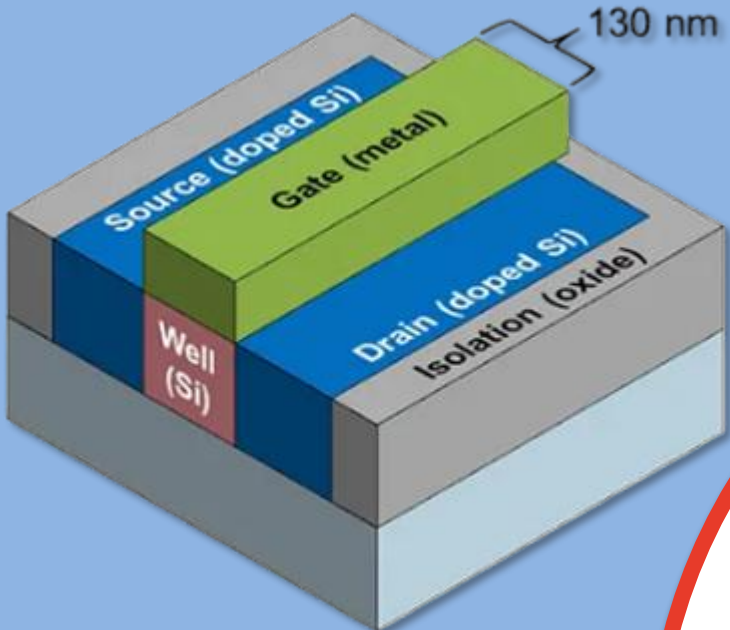


Figure 3: 3D image of a transistor [2].

3T0C Cell and Array Architecture

Each 3T0C cell integrates two IGZO transistors (M1, M2) for low-leakage storage/access and a silicon cascode transistor (M3) for read-path isolation and for fast discharge. IGZO’s off-current preserves data; silicon’s mobility accelerates sensing.

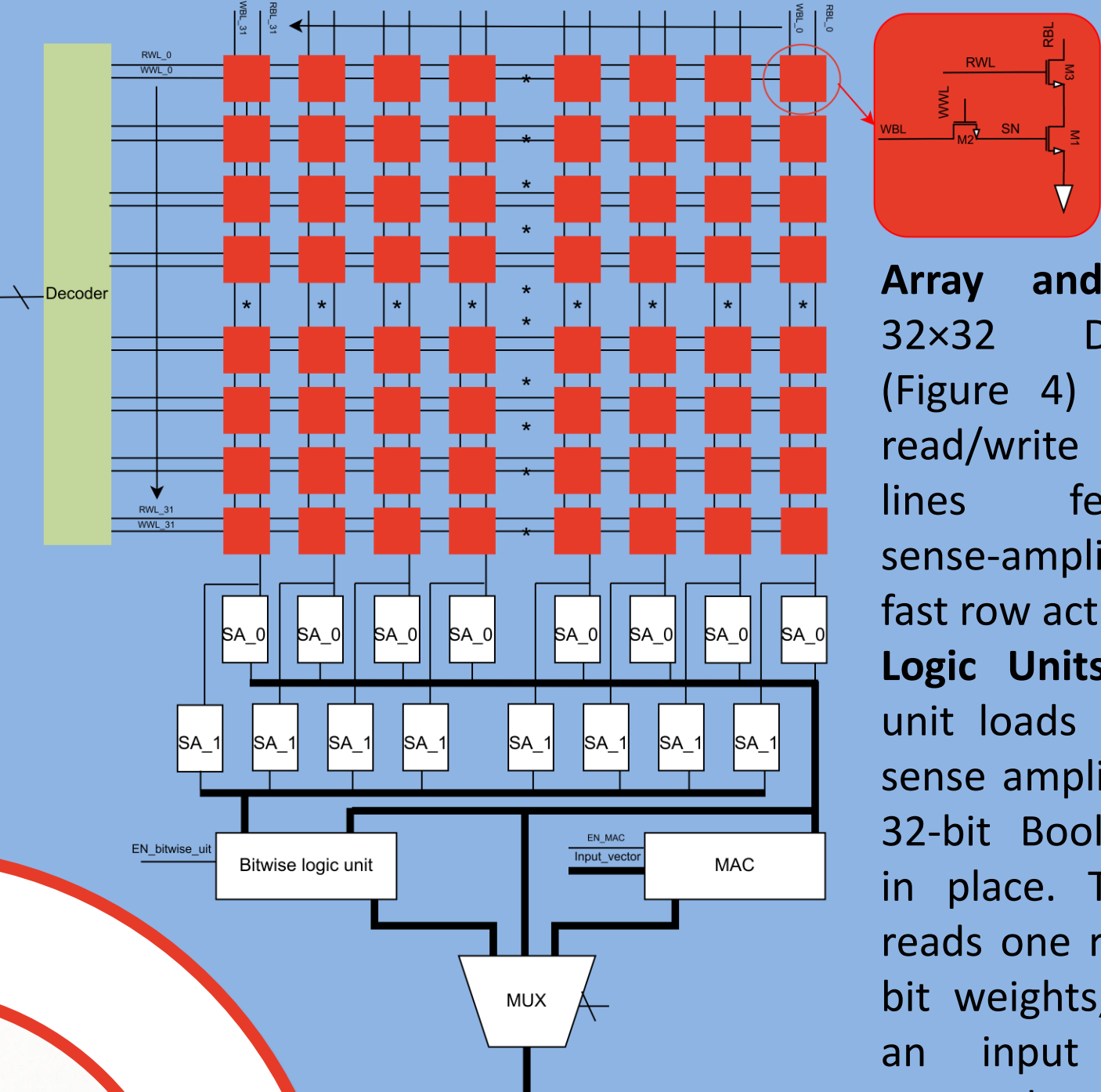


Figure 4: Proposed 32x32 array architecture.

Array and Sensing: A 32x32 DRAM array (Figure 4) uses separate read/write word and bit lines feeding two sense-amplifier banks for fast row activation.

Logic Units: The bitwise unit loads two rows into sense amplifiers, applies a 32-bit Boolean operation in place. The MAC unit reads one row as eight 4-bit weights, multiplies by an input vector, and accumulates the dot product.

IMC

Hybrid IGZO–Si 3T0C DRAM achieves over 400 s retention, ~6 450x silicon-only, while delivering 50 ns/55 ns read/write at 116 pJ/131 pJ (table 1). In-memory bitwise (85 ns, 232 pJ) and MAC (55 ns, 144 pJ) operations enable low-energy, high-throughput compute near memory efficiently.

Table 1: Comparison to the state of Art.

	Gitterman et al.	Ryu et al.	This Work
Write Access Time	1.3 ns	9.1 μs	55 ns
Write Energy	N/A	N/A	131 pJ
Read Access Time	25 ns	9.1 μs	50 ns
Read Energy	N/A	N/A	116 pJ
Retention	< 0.8 ms	> 1000 s	> 400 s

Outlook

Scaling to larger arrays requires analyzing interconnect parasitics, IR drop, and exploring monolithic 3D stacking of IGZO on silicon logic to reduce routing overhead. Advanced sense amplifiers with adaptive biasing and column-parallel activation may lower read latency below 50 ns. Per-bit logic cells or analog compute primitives could enable single-cycle, array-wide operations. End-to-end benchmarks on sparse and bitwise neural workloads and compiler-driven ISA extensions will quantify performance and energy benefits.

Device-level:

All simulations were performed in Cadence. Device-level SPICE models for IGZO transistors were provided by Pragmatic; the silicon cascode model by X-FAB. The logic units and the controller were implemented in VHDL, simulated in Vivado, synthesized with the Genus tool using X-FAB standard cells, and their functional and timing data were back-annotated into circuit simulations.

Device-level simulation

Circuits-level simulation

System-level simulation

